

Notice of References Cited	Application/Control No. 10/574,383		Applicant(s)/Patent Under Reexamination AKASHI ET AL.	
	Examiner AMENE S. BAYOU		Art Unit 3746	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0191094	09-2004	Kojima et al.	417/415
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 2001073948 A	03-2001	Japan	Fumitoshi	
*	O	WO 0106624 A1	01-2001	World Intellect	Sasaki et al.	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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